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## Structure Reports

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## 4,4'-Bis(trimethylsilyl)-2,2'-bipyridine

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Key indicators: single-crystal X-ray study; $T=223 \mathrm{~K}$; mean $\sigma(\mathrm{C}-\mathrm{C})=0.003 \AA$; $R$ factor $=0.046 ; w R$ factor $=0.125$; data-to-parameter ratio $=17.4$.

In the molecule of title compound, $\mathrm{C}_{16} \mathrm{H}_{24} \mathrm{~N}_{2} \mathrm{Si}_{2}$, the pyridine rings are nearly planar (r.m.s. deviation $=0.002 \AA$ ).

## Related literature

For the structure of 5,5'-bis(trimethylsilyl)-2,2'-bipyridines, see: Stange et al. (2000). For the structure of 4-trimethylsilylpyridine, see: Postigo \& Rossi (2001). For synthetic procedure to obtain 4,4'-bis(methoxyl)-2,2'-bipyridine, see: Wenkert \& Woodward (1983).


## Experimental

Crystal data
$\mathrm{C}_{16} \mathrm{H}_{24} \mathrm{~N}_{2} \mathrm{Si}_{2}$
$M_{r}=300.55$

Monoclinic, $P 2_{1} / c$
$a=13.154$ (4) $\AA$
$b=6.4599$ (16) $\AA$
$c=11.280(3) \AA$
$\beta=111.222$ (6) ${ }^{\circ}$
$V=893.5(4) \AA^{3}$
$Z=2$
Mo $K \alpha$ radiation
$\mu=0.19 \mathrm{~mm}^{-1}$
$T=223 \mathrm{~K}$
$0.50 \times 0.30 \times 0.20 \mathrm{~mm}$

## Data collection

Rigaku Saturn CCD diffractometer Absorption correction: multi-scan (SADABS; Sheldrick, 1996)
$T_{\text {min }}=0.869, T_{\text {max }}=0.963$

## Refinement

$R\left[F^{2}>2 \sigma\left(F^{2}\right)\right]=0.046$
$w R\left(F^{2}\right)=0.125$
$S=1.08$
1649 reflections
95 parameters

4311 measured reflections 1649 independent reflections 1364 reflections with $I>2 \sigma(I)$ $R_{\text {int }}=0.027$

Data collection: CrystalClear (Rigaku, 2005); cell refinement: CrystalClear; data reduction: CrystalClear; program(s) used to solve structure: SHELXS97 (Sheldrick, 2008); program(s) used to refine structure: SHELXL97 (Sheldrick, 2008); molecular graphics: PLATON (Spek, 2009); software used to prepare material for publication: SHELXL97.

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Supplementary data and figures for this paper are available from the IUCr electronic archives (Reference: RK2303).

## References

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## supplementary materials

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## 4,4'-Bis(trimethylsilyl)-2,2'-bipyridine

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## Comment

Derivatives of $2,2^{\prime}$-bipyridine have received much attention due to their potential to form polypyridyl metal complexes, particularly of ruthenium and rhenium which have diverse applications. The photochemical and redox properties of these complexes can be varied through appropriate substitution on the pyridine rings. The derivatization of a 2,2'-bipyridine ligand with electron donating/withdrawing groups in the 4,4'-positions has been a popular means of controlling the redox potential of transition metal bipyridine complexes. The 4,4'-disubstitution can also offers no steric complications on complexation. The research about synthesis and properties of pyridine rings interconnected with strong electron-donating groups, as well as trimethysilyl group, was recently reported (Stange et al., 2000; Postigo \& Rossi, 2001). However, there are no reports on 4,4'-bis(trimethylsilyl)-2,2'-bipyridine. Herein, we report crystal structure of the title compound.

The molecule is placed in centre of symmetry and nealy flat (Fig. 1) as the $\mathrm{C}-\mathrm{Si}$ is co-planar with the aromatic rings. The torsion angle for $\mathrm{N} 1-\mathrm{C} 4-\mathrm{C} 4^{\mathrm{i}}-\mathrm{C} 5^{\mathrm{i}}=0^{\circ}$. In crystal, molecules are connected by weak non-classical intermolecular $\mathrm{C} 3-\mathrm{H} 3 \cdots \mathrm{~N} 1^{\mathrm{ii}}$ hydrogen bonds with parameters $\mathrm{C} 3 \cdots \mathrm{~N} 1^{\mathrm{ii}}=3.626$ (2) $\AA, \mathrm{H} 3 \cdots \mathrm{~N} 1^{\mathrm{ii}}=2.714 \AA$ and angle $\mathrm{C} 3-\mathrm{H} 3 \cdots \mathrm{~N} 1^{\mathrm{ii}}=$ $164.3^{\circ}$. Symmetry codes: (i) $-x+1,-y+1,-z$; (ii) $-x+1, y-1 / 2,-z+1 / 2$.

## Experimental

All the reagents and solvents empolyed were commercially available. The title compound was synthesized by using $2,2^{\prime}-$ bipyridine as the starting material with successive polystepreactions (Wenkert \& Woodward, 1983). The final product was dissolved in the solution of methanol and methylene chloride, which diffused slowly. After seven days, colourless blockshaped crystals were obtained which were suitable for X-ray analysis.

## Refinement

All H atoms were placed in geometrically idealized positions. H atoms of bipyridine constrained to ride on their parent atoms with $\mathrm{C}-\mathrm{H}=0.94 \AA$ and refined with $U_{\text {iso }}(\mathrm{H})=1.2 U_{\mathrm{iso}}(\mathrm{C})$. The H atoms of methyl groups constrained to ride on their parent atoms with $\mathrm{C}-\mathrm{H}=0.97 \AA$ and refined with $U_{\text {iso }}(\mathrm{H})=1.5 U_{\text {iso }}(\mathrm{C})$.

## Figures



Fig. 1. Molecular structure of title compound with the atom numbering scheme. Displacement ellipsoids are drawn at $40 \%$ probability level. H atoms are presented as a small spheres of arbitrary radius. Symmetry code: (i) $-x+1,-y+1,-z$.

## supplementary materials

## 4,4'-Bis(trimethylsilyl)-2,2'-bipyridine

## Crystal data

$\mathrm{C}_{16} \mathrm{H}_{24} \mathrm{~N}_{2} \mathrm{Si}_{2}$
$F(000)=324$
$M_{r}=300.55$
Monoclinic, $P 2_{1} / c$
Hall symbol: -P 2ybc
$a=13.154$ (4) $\AA$
$b=6.4599$ (16) $\AA$
$c=11.280(3) \AA$
$\beta=111.222(6)^{\circ}$
$V=893.5(4) \AA^{3}$
$Z=2$
$D_{\mathrm{x}}=1.117 \mathrm{Mg} \mathrm{m}^{-3}$
Mo $K \alpha$ radiation, $\lambda=0.71075 \AA$
Cell parameters from 3568 reflections
$\theta=3.2-27.5^{\circ}$
$\mu=0.19 \mathrm{~mm}^{-1}$
$T=223 \mathrm{~K}$
Block, colourless
$0.50 \times 0.30 \times 0.20 \mathrm{~mm}$

## Data collection

Rigaku Saturn CCD
diffractometer
Radiation source: fine-focus sealed tube
graphite
Detector resolution: 14.63 pixels $\mathrm{mm}^{-1}$
$\omega$ scans
Absorption correction: multi-scan
(SADABS; Sheldrick, 1996)
$T_{\text {min }}=0.869, T_{\text {max }}=0.963$
1649 independent reflections
1364 reflections with $I>2 \sigma(I)$
$R_{\text {int }}=0.027$
$\theta_{\max }=25.5^{\circ}$
$h=-13 \rightarrow 15$
$k=-7 \rightarrow 7$
$l=-13 \rightarrow 12$
4311 measured reflections

## Refinement

Refinement on $F^{2}$
Least-squares matrix: full
$R\left[F^{2}>2 \sigma\left(F^{2}\right)\right]=0.046$
$w R\left(F^{2}\right)=0.125$
$S=1.08$
1649 reflections
Primary atom site location: structure-invariant direct methods
Secondary atom site location: difference Fourier map
Hydrogen site location: inferred from neighbouring sites

H -atom parameters constrained
$w=1 /\left[\sigma^{2}\left(F_{\mathrm{o}}{ }^{2}\right)+(0.0734 P)^{2}+0.0832 P\right]$
where $P=\left(F_{\mathrm{o}}^{2}+2 F_{\mathrm{c}}^{2}\right) / 3$
$(\Delta / \sigma)_{\max }<0.001$
95 parameters
2 restraints
$\Delta \rho_{\max }=0.25$ e $\AA^{-3}$
$\Delta \rho_{\text {min }}=-0.26$ e $\AA^{-3}$

## Special details

Geometry. All s.u.'s (except the s.u. in the dihedral angle between two 1.s. planes) are estimated using the full covariance matrix. The cell s.u.'s are taken into account individually in the estimation of s.u.'s in distances, angles and torsion angles; correlations between
s.u.'s in cell parameters are only used when they are defined by crystal symmetry. An approximate (isotropic) treatment of cell s.u.'s is used for estimating s.u.'s involving 1.s. planes.

Refinement. Refinement of $F^{2}$ against ALL reflections. The weighted $R$-factor $w R$ and goodness of fit $S$ are based on $F^{2}$, conventional $R$-factors $R$ are based on $F$, with $F$ set to zero for negative $F^{2}$. The threshold expression of $F^{2}>\sigma F^{2}$ is used only for calculating $R$ factors(gt) etc. and is not relevant to the choice of reflections for refinement. $R$-factors based on $F^{2}$ are statistically about twice as large as those based on $F$, and $R$-factors based on ALL data will be even larger.

Fractional atomic coordinates and isotropic or equivalent isotropic displacement parameters ( $A^{2}$ )

|  | $x$ | $y$ | $z$ | $U_{\text {iso }}{ }^{*} U_{\text {eq }}$ |
| :--- | :--- | :--- | :--- | :--- |
| Si1 | $0.80366(4)$ | $0.08423(9)$ | $0.02023(5)$ | $0.0405(2)$ |
| N1 | $0.49321(13)$ | $0.2932(2)$ | $0.10461(14)$ | $0.0366(4)$ |
| C1 | $0.68120(15)$ | $0.1675(3)$ | $0.05735(17)$ | $0.0356(5)$ |
| C2 | $0.64022(16)$ | $0.0538(3)$ | $0.13516(18)$ | $0.0383(5)$ |
| H2 | 0.6754 | -0.0686 | 0.1740 | $0.046^{*}$ |
| C3 | $0.54791(17)$ | $0.1206(3)$ | $0.15535(18)$ | $0.0391(5)$ |
| H3 | 0.5221 | 0.0400 | 0.2079 | $0.047^{*}$ |
| C4 | $0.53132(15)$ | $0.4054(3)$ | $0.02861(17)$ | $0.0311(4)$ |
| C5 | $0.62411(16)$ | $0.3477(3)$ | $0.00480(17)$ | $0.0353(5)$ |
| H5 | 0.6487 | 0.4314 | -0.0475 | $0.042^{*}$ |
| C6 | $0.8938(2)$ | $-0.0751(5)$ | $0.1542(3)$ | $0.0724(9)$ |
| H6A | 0.8573 | -0.2038 | 0.1584 | $0.109^{*}$ |
| H6B | 0.9101 | 0.0003 | 0.2333 | $0.109^{*}$ |
| H6C | 0.9611 | -0.1049 | 0.1408 | $0.109^{*}$ |
| C7 | $0.7569(2)$ | $-0.0682(4)$ | $-0.1293(2)$ | $0.0576(6)$ |
| H7A | 0.8197 | -0.1205 | -0.1457 | $0.086^{*}$ |
| H7B | 0.7140 | 0.0195 | -0.1993 | $0.086^{*}$ |
| H7C | 0.7127 | -0.1834 | -0.1210 | $0.06^{*}$ |
| C8 | $0.8778(2)$ | $0.3196(4)$ | $0.0009(3)$ | $0.0687(7)$ |
| H8A | 0.8948 | 0.4060 | 0.0760 | $0.103^{*}$ |
| H8B | 0.8323 | 0.3964 | -0.0732 | $0.103^{*}$ |
| H8C | 0.9448 | 0.2790 | -0.0101 | $0.103^{*}$ |

Atomic displacement parameters $\left(\AA^{2}\right)$

|  | $U^{11}$ | $U^{22}$ | $U^{33}$ | $U^{12}$ | $U^{13}$ | $U^{23}$ |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| Si1 | $0.0418(4)$ | $0.0433(4)$ | $0.0397(4)$ | $0.0085(2)$ | $0.0189(3)$ | $0.0001(2)$ |
| N1 | $0.0437(9)$ | $0.0376(9)$ | $0.0332(8)$ | $0.0016(7)$ | $0.0195(7)$ | $0.0033(7)$ |
| C1 | $0.0387(10)$ | $0.0352(10)$ | $0.0323(9)$ | $0.0035(8)$ | $0.0120(8)$ | $-0.0037(8)$ |
| C2 | $0.0451(11)$ | $0.0361(10)$ | $0.0339(10)$ | $0.0059(9)$ | $0.0144(9)$ | $0.0028(8)$ |
| C3 | $0.0496(12)$ | $0.0373(11)$ | $0.0347(10)$ | $-0.0001(9)$ | $0.0202(9)$ | $0.0051(8)$ |
| C4 | $0.0368(10)$ | $0.0307(9)$ | $0.0277(9)$ | $-0.0011(8)$ | $0.0139(8)$ | $-0.0013(7)$ |
| C5 | $0.0410(10)$ | $0.0377(10)$ | $0.0317(9)$ | $0.0005(8)$ | $0.0185(8)$ | $-0.0008(8)$ |
| C6 | $0.0688(17)$ | $0.093(2)$ | $0.0590(15)$ | $0.0392(15)$ | $0.0270(14)$ | $0.0160(14)$ |
| C7 | $0.0642(15)$ | $0.0625(15)$ | $0.0532(13)$ | $0.0052(12)$ | $0.0297(12)$ | $-0.0119(11)$ |
| C8 | $0.0544(14)$ | $0.0656(16)$ | $0.097(2)$ | $-0.0045(13)$ | $0.0409(14)$ | $-0.0089(15)$ |

Geometric parameters ( $A,{ }^{\circ}$ )

| Si1-C7 | 1.855 (2) |
| :---: | :---: |
| Si1-C6 | 1.858 (2) |
| Si1-C8 | 1.861 (3) |
| Si1-C1 | 1.884 (2) |
| N1-C3 | 1.338 (2) |
| N1-C4 | 1.350 (2) |
| C1-C2 | 1.394 (3) |
| C1-C5 | 1.396 (3) |
| C2-C3 | 1.383 (3) |
| C2-H2 | 0.9400 |
| C3-H3 | 0.9400 |
| $\mathrm{C} 4-\mathrm{C} 5$ | 1.392 (3) |
| C7-Si1-C6 | 110.44 (13) |
| C7-Si1-C8 | 110.03 (13) |
| C6-Si1-C8 | 109.91 (14) |
| C7-Si1-C1 | 108.97 (10) |
| C6-Sil-C1 | 108.84 (11) |
| C8-Si1-C1 | 108.60 (10) |
| C3-N1-C4 | 116.95 (17) |
| C2-C1-C5 | 115.83 (18) |
| C2-C1-Si1 | 123.10 (15) |
| C5-C1-Sil | 121.05 (15) |
| C3-C2-C1 | 120.11 (18) |
| C3-C2-H2 | 119.9 |
| C1-C2-H2 | 119.9 |
| N1-C3-C2 | 123.92 (18) |
| N1-C3-H3 | 118.0 |
| C2-C3-H3 | 118.0 |
| N1-C4-C5 | 122.12 (17) |
| N1-C4-C4 ${ }^{\text {i }}$ | 116.3 (2) |
| C5-C4-C4 ${ }^{\text {i }}$ | 121.6 (2) |
| C4-C5-C1 | 121.06 (18) |
| C7-Si1-C1-C2 | 92.79 (18) |
| C6-Si1-C1-C2 | -27.7 (2) |
| C8-Si1- $\mathrm{C} 1-\mathrm{C} 2$ | -147.35 (18) |
| C7-Si1-C1-C5 | -85.66 (18) |
| C6-Si1-C1-C5 | 153.85 (17) |
| C8-Si1-C1-C5 | 34.20 (19) |
| C5-C1-C2-C3 | 0.5 (3) |
| Si1-C1-C2-C3 | -178.01 (14) |

Symmetry codes: (i) $-x+1,-y+1,-z$.

Hydrogen-bond geometry (A, ${ }^{\circ}$ )
$D — H \cdots A$
$D-\mathrm{H}$
$\mathrm{H} \cdots A$
$D \cdots A$
$D-\mathrm{H} \cdots A$

## sup-4

## supplementary materials

| $\mathrm{C} 3 — \mathrm{H} 3 \cdots \mathrm{~N} 1^{\mathrm{ii}}$ | 0.94 | 2.71 | $3.626(2)$ | 164. |
| :--- | :--- | :--- | :--- | :--- |

Symmetry codes: (ii) $-x+1, y-1 / 2,-z+1 / 2$.

Fig. 1


